International TOR Rectifier

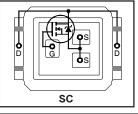
AUTOMOTIVE GRADE

AUIRF7647S2TR AUIRF7647S2TR1

- Advanced Process Technology
- Optimized for Class D Audio Amplifier Applications
- Low Rds(on) for Improved Efficiency
- Low Qg for Better THD and Improved Efficiency
- Low Qrr for Better THD and Lower EMI
- Low Parasitic Inductance for Reduced Ringing and Lower EMI
- Delivers up to 100W per Channel into 8Ω with No Heatsink
- Dual Sided Cooling
- 175°C Operating Temperature
- · Repetitive Avalanche Capability for Robustness and Reliability
- Lead free, RoHS and Halogen free

DirectFET™ Power MOSFET ②

V _{(BR)DSS}	100V
R _{DS(on)} typ.	26m Ω
max.	31m Ω
R _{G (typical)}	1.6 Ω
Q _{g (typical)}	14nC





Applicable DirectFET Outline and Substrate Outline ①

SB SC M2 M4 L4 L6 L8

Description

The AUIRF7647S2TR/TR1 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET packaging platform to produce a best in class part for Automotive Class D audio amplifier applications. The DirectFET package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET Power MOSFET optimizes gate charge, body diode reverse recovery and internal gate resistance to improve key Class D audio amplifier performance factors such as efficiency, THD and EMI. Moreover the DirectFET packaging platform offers low parasitic inductance and resistance when compared to conventional wire bonded SOIC packages which improves EMI performance by reducing the voltage ringing that accompanies current transients. These features combine to make this MOSFET a highly desirable component in Automotive Class D audio amplifier systems.

Absolute Maximum Ratings

	Parameter	Max.	Units	
V _{DS}	Drain-to-Source Voltage	100	.,,	
V _{GS}	Gate-to-Source Voltage	± 20	† V	
_D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	24		
D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	17		
D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)③	5.9	A	
DM	Pulsed Drain Current @	95		
P _D @T _C = 25°C	Power Dissipation	41	w	
P _D @T _A = 25°C	Power Dissipation ③	2.5	7 vv	
AS	Single Pulse Avalanche Energy (Thermally Limited) ®	45	mJ	
AS(tested)	Single Pulse Avalanche Energy (Tested Value) ©	67	IIIJ	
AR	Avalanche Current ⑤	Coo Fig. 10o 10b 16 17	Α	
-AR	Repetitive Avalanche Energy ©	See Fig. 18a,18b,16,17	mJ	
Γ _P	Peak Soldering Temperature	270		
ГЈ	Operating Junction and	-55 to + 175	°C	
Г _{STG}	Storage Temperature Range			

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③		60	
$R_{\theta JA}$	Junction-to-Ambient ®	12.5		
$R_{\theta JA}$	Junction-to-Ambient ®	20		°C/W
$R_{\theta J\text{-Can}}$	Junction-to-Can ⊕®		3.7	
R _{0J-PCB}	Junction-to-PCB Mounted	1.4		
1	Linear Derating Factor ®	0.	27	W/°C

HEXFET® is a registered trademark of International Rectifier.

Static @ $T_J = 25$ °C (unless otherwise specified)

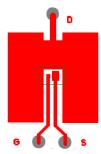
	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	_	0.10		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance	_	26	31	mΩ	V _{GS} = 10V, I _D = 14A ⑦
$V_{GS(th)}$	Gate Threshold Voltage	3.0	4.0	5.0	V	$V_{DS} = V_{GS}$, $I_D = 50\mu A$
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient		-13		mV/°C	V _{DS} = V _{GS} , I _D = 30μA
gfs	Forward Transconductance	16			S	$V_{DS} = 25V, I_{D} = 14A$
R _{G(int)}	Internal Gate Resistance		1.6		Ω	
I _{DSS}	Drain-to-Source Leakage Current	_		5.0	μΑ	$V_{DS} = 100V, V_{GS} = 0V$
				250		$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100		V _{GS} = -20V

Dynamic @ T_J = 25°C (unless otherwise specified)

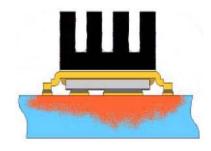
	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		14	21		$V_{DS} = 50V$
Q _{gs1}	Pre-Vth Gate-to-Source Charge		3.3			V _{GS} = 10V
Q _{gs2}	Post-Vth Gate-to-Source Charge		1.3		nC	I _D = 14A
Q_{gd}	Gate-to-Drain Charge		5.3			See Fig. 11
Q_{godr}	Gate Charge Overdrive		4.1			
Q_{sw}	Switch Charge (Q _{gs2} + Q _{gd})		6.6			
Q _{oss}	Output Charge		7.6		nC	$V_{DS} = 16V, V_{GS} = 0V$
t _{d(on)}	Turn-On Delay Time		5.5			$V_{DD} = 50V$
t _r	Rise Time		8.4			I _D = 14A
t _{d(off)}	Turn-Off Delay Time		7.9		ns	$R_G = 6.8\Omega$
t _f	Fall Time		4.6			V _{GS} = 10V ⑦
C _{iss}	Input Capacitance		910			$V_{GS} = 0V$
Coss	Output Capacitance		190			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		47		pF	f = 1.0MHz
C _{oss}	Output Capacitance		960			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
Coss	Output Capacitance		115]	$V_{GS} = 0V, V_{DS} = 80V, f = 1.0MHz$
C _{oss} eff.	Effective Output Capacitance		190		1	$V_{GS} = 0V$, $V_{DS} = 0V$ to $80V$

Diode Characteristics

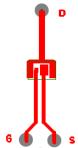
	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			24		MOSFET symbol
	(Body Diode)			24	Α	showing the
I _{SM}	Pulsed Source Current			95	Ī	integral reverse
	(Body Diode) ⑤			95		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$, $I_S = 14A$, $V_{GS} = 0V$ ⑦
t _{rr}	Reverse Recovery Time		37		ns	$T_J = 25^{\circ}C$, $I_F = 14A$, $V_{DD} = 25V$
Q _{rr}	Reverse Recovery Charge		55		nC	di/dt = 100A/µs ⑦



③ Surface mounted on 1 in. square Cu (still air).



 Mounted to a PCB with small clip heatsink (still air)



9 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

Notes ① through ⑩ are on page 11

2

Qualification Information[†]

		Automotive (per AEC-Q101) ††			
Qualification Leve	el	Comments: This part number(s) passed Automotive qualification IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture Sensitivity Level		DFET2 MSL1			
	Machine Model	M4 (>400V)			
		AEC-Q101-002			
500	Human Body Model		H1A (≤500V)		
ESD		AEC-Q101-001			
	Charged Device	C4 (≤1000V)			
	Model	AEC-Q101-005			
RoHS Compliant		Yes			

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com

^{††} Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

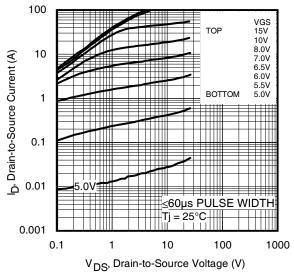
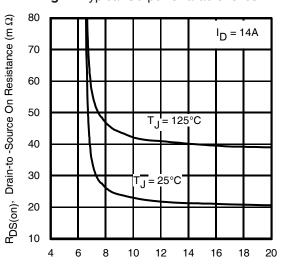


Fig 1. Typical Output Characteristics



 $\label{eq:VGS} V_{GS,\;\text{Gate -to -Source Voltage}} \text{ (V)} \\ \textbf{Fig 3.} \quad \text{Typical On-Resistance vs. Gate Voltage}$

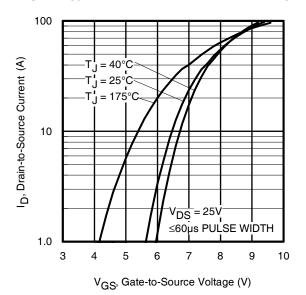


Fig 5. Typical Transfer Characteristics

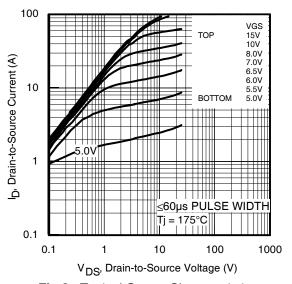


Fig 2. Typical Output Characteristics

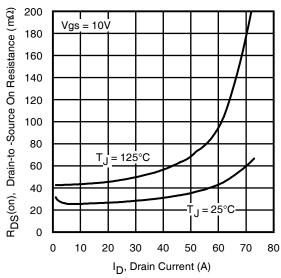


Fig 4. Typical On-Resistance vs. Drain Current

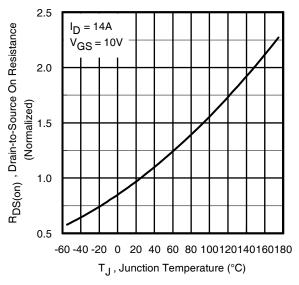


Fig 6. Normalized On-Resistance vs. Temperature

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4

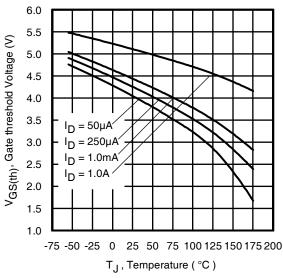


Fig 7. Typical Threshold Voltage vs. Junction Temperature

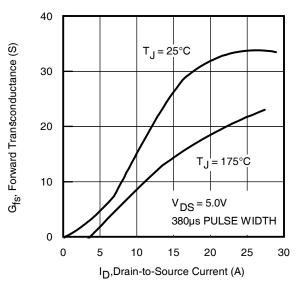


Fig 9. Typical Forward Transconductance vs. Drain Current

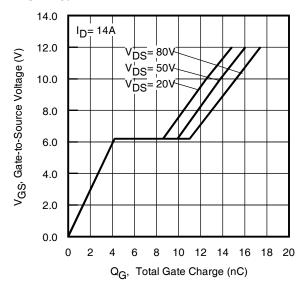


Fig.11 Typical Gate Charge vs.Gate-to-Source Voltage www.irf.com

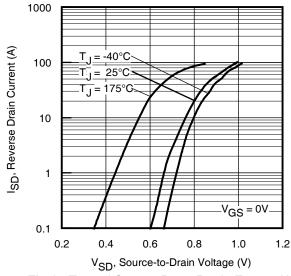


Fig 8. Typical Source-Drain Diode Forward Voltage

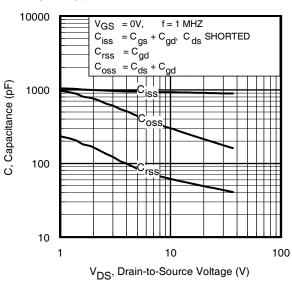


Fig 10. Typical Capacitance vs.Drain-to-Source Voltage

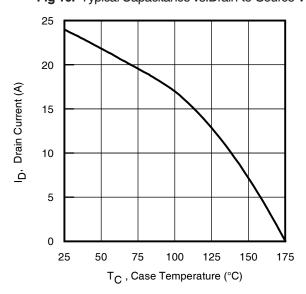


Fig 12. Maximum Drain Current vs. Case Temperature

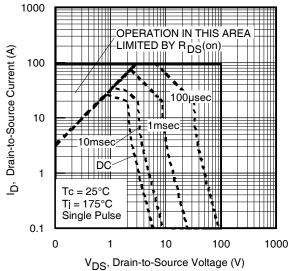


Fig 13. Maximum Safe Operating Area

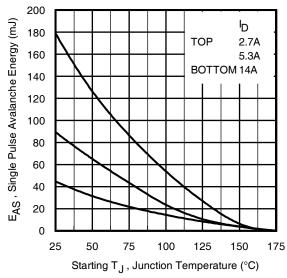


Fig 14. Maximum Avalanche Energy vs. Temperature

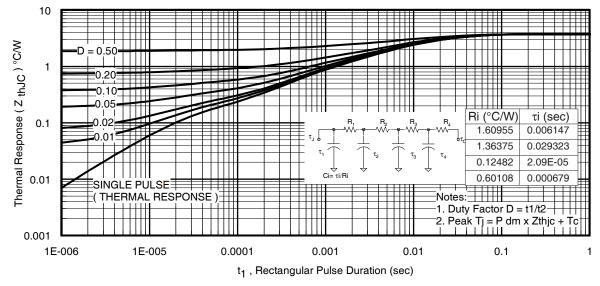


Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

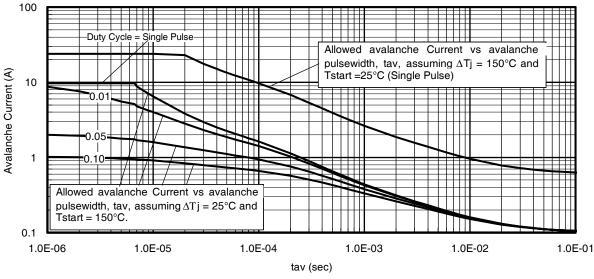


Fig 16. Typical Avalanche Current vs. Pulsewidth

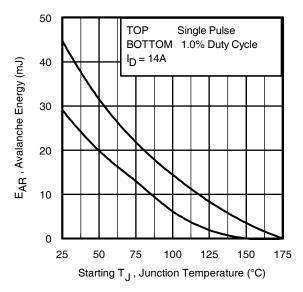


Fig 17. Maximum Avalanche Energy vs. Temperature

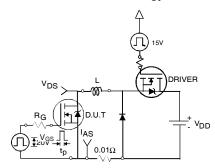


Fig 18a. Unclamped Inductive Test Circuit

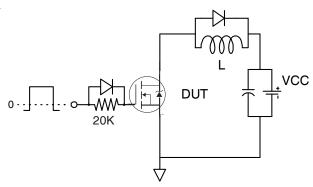


Fig 19a. Gate Charge Test Circuit

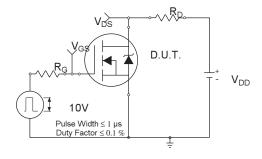


Fig 20a. Switching Time Test Circuit

Notes on Repetitive Avalanche Curves , Figures 16, 17: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for
- 2. Safe operation in Avalanche is allowed as long asT_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 16, 17).

t_{av =} Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{th,IC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D\;(ave)} &= 1/2\;(\;1.3 \cdot BV \cdot I_{av}) = \Delta T/\;Z_{thJC} \\ I_{av} &= 2\Delta T/\;[1.3 \cdot BV \cdot Z_{th}] \\ E_{AS\;(AR)} &= P_{D\;(ave)} \cdot t_{av} \end{split}$$

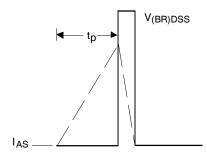


Fig 18b. Unclamped Inductive Waveforms

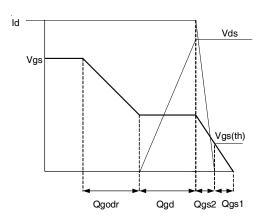


Fig 19b. Gate Charge Waveform

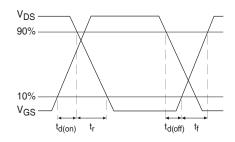
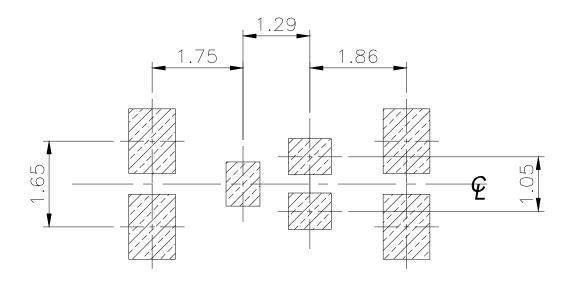
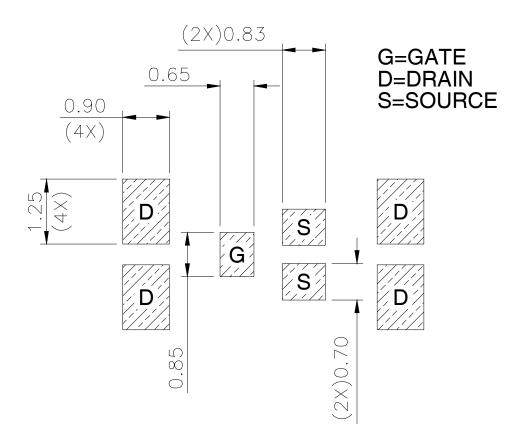


Fig 20b. Switching Time Waveforms

Automotive DirectFET™ Board Footprint, SC (Small Size Can).

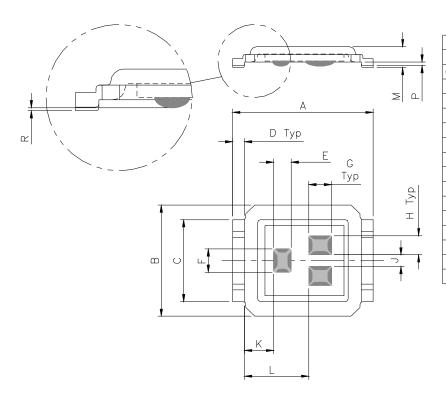
Please see AN-1035 for DirectFET assembly details and stencil and substrate design recommendations





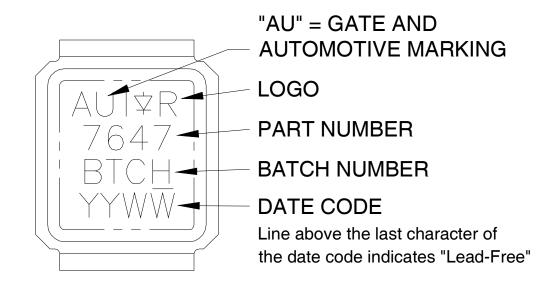
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Automotive DirectFET™ Outline Dimension, SC Outline (Small Size Can). Please see AN-1035 for DirectFET assembly details and stencil and substrate design recommendations

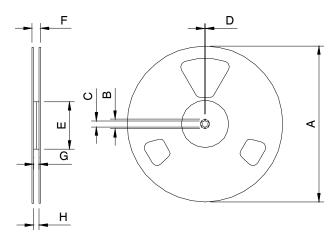


	DIMENSIONS							
	METRIC		IMPE	RIAL				
CODE	MIN	MAX	MIN	MAX				
Α	4.75	4.85	0.187	0.191				
В	3.70	3.95	0.146	0.156				
С	2.75	2.85	0.108	0.112				
D	0.35	0.45	0.014	0.018				
Е	0.58	0.62	0.023	0.024				
F	0.78	0.82	0.031	0.032				
G	0.75	0.80	0.030	0.031				
Н	0.63	0.67	0.025	0.026				
J	0.38	0.42	0.015	0.016				
K	0.95	1.05	0.037	0.041				
L	2.15	2.25	0.085	0.088				
М	0.68	0.74	0.027	0.029				
Р	0.08	0.17	0.003	0.007				
R	0.02	0.08	0.001	0.003				

Automotive DirectFET™ Part Marking

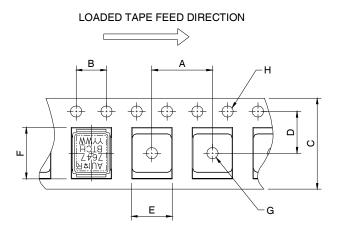


Automotive DirectFET™ Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts. (ordered as AUIRF7647S2TR). For 1000 parts on 7" reel, order AUIRF7647S2TR1

			REI	EL DIMEN	ISIONS			
S.	TANDARI	OPTION	I (QTY 48	00)	TR	1 OPTION	(QTY 10	00)
	ME	TRIC	IMP	ERIAL	ME	TRIC	IMP	ERIAL
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX
Α	330.0	N.C	12.992	N.C	177.77	N.C	6.9	N.C
В	20.2	N.C	0.795	N.C	19.06	N.C	0.75	N.C
С	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50
D	1.5	N.C	0.059	N.C	1.5	N.C	0.059	N.C
Е	100.0	N.C	3.937	N.C	58.72	N.C	2.31	N.C
F	N.C	18.4	N.C	0.724	N.C	13.50	N.C	0.53
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C
Н	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS								
	MET	RIC	IMPE	RIAL				
CODE	MIN	MAX	MIN	MAX				
Α	7.90	8.10	0.311	0.319				
В	3.90	4.10	0.154	0.161				
С	11.90	12.30	0.469	0.484				
D	5.45	5.55	0.215	0.219				
E	4.00	4.20	0.158	0.165				
F	5.00	5.20	0.197	0.205				
G	1.50	N.C	0.059	N.C				
Н	1.50	1 60	0.059	0.063				

Notes:

- $\ensuremath{\mathbb{O}}$ Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- ④ T_C measured with thermocouple mounted to top (Drain) of part.
- ⑤ Repetitive rating; pulse width limited by max. junction temperature.
- © Starting $T_J = 25$ °C, L = 0.46mH, $R_G = 25Ω$, $I_{AS} = 14$ A.
- ⑦ Pulse width ≤ 400 μ s; duty cycle ≤ 2%.
- ® Used double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- 1 R₀ is measured at T_J of approximately 90°C.

10 www.irf.com

International

TOR Rectifier

AUIRF7647S2TR/TR1

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For technical support, please contact IR's Technical Assistance Center http://www.irf.com/technical-info/

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